

Name: Sarah Bagasol

Title:

Quality Assurance Specialist

## **CERTIFICATE OF ANALYSIS**

This certificate is provided to confirm that the diagnostic kit specified below conforms to the production and testing specifications required by Cepheid's Quality System, in compliance with the US Food and Drug Administration's Quality System Requirements, ISO 13485, European IVD Directive, the Canadian Medical Devices Regulations (CMDR), and the China National Medical Products Administration's Quality System Requirements.

it Lot No.: 1001443654			
Cartridge Lot No.: 60307			
Kit Expiration Date: 2026 02	15		
egal Manufacturer	<b>Manufacturing Facility</b>		
Cepheid AB	Cepheid	Solna	O St
Röntgenvägen 5	121 N Guild Avenue	O Some	
E-17154 Solna	Lodi, CA 95240		
Functional Testing accordin		Lodi  Test Rev	sult
Functional Testing accordin	g to D25862, Rev. AN  Acceptance Criteria	Lodi  Test Res	sult
Functional Testing accordin  Test Description	g to D25862, Rev. AN		sult
Functional Testing accordin  Test Description	Acceptance Criteria  MTB DETECTED VERY LOW; Rif Resistance NOT DETECTED or MTB DETECTED LOW; Rif Resistance NOT DETECTED or MTB DETECTED MEDIUM; Rif Resistance NOT DETECTED		
Weden  Functional Testing according  Test Description  Wild Type Control	Acceptance Criteria  MTB DETECTED VERY LOW; Rif Resistance NOT DETECTED or MTB DETECTED LOW; Rif Resistance NOT DETECTED or Or OT DETECTED OR OT DETECTED OR OT DETECTED OT OT DETECTED OT OT DETECTED OT OT DETECTED OT OT	Test Res	
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Test Description  Wild Type Control  Mutant Control  Negative	Acceptance Criteria  MTB DETECTED VERY LOW; Rif Resistance NOT DETECTED or MTB DETECTED LOW; Rif Resistance NOT DETECTED or MTB DETECTED MEDIUM; Rif Resistance NOT DETECTED or MTB DETECTED HIGH; Rif Resistance NOT DETECTED MTB DETECTED URTH Resistance NOT DETECTED OR MTB DETECTED VERY LOW; RIF Resistance DETECTED OR MTB DETECTED LOW; RIF Resistance DETECTED OR MTB DETECTED MEDIUM; RIF Resistance DETECTED	Passe Passe Passe	ed ed